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			Application	Application 17536861 OFGS			S File No. P/2107-277			
APPLI	CANT	'S ART CITATIO								
(Us€	e several	sheets if necessary)	<u> </u>	Christoph WAGNER et al						
			Filing Date	Filing Date		Group Art Unit				
			U.S. 1	PATENT DOCUMENTS	,					
Examiner Initial	Dc	ocument Number	Date MM-YYYY	Date 1-YYYY Name		Sub- class	Filin If App	g Date propriate		
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		NT	Date MM-YYYY		Class	Sub- class	Translation			
	Do	ocument Number	141141- 1 1 1 1	Country			Yes	No		
	2000)-097641	04-2000	Japan	<u> </u>					
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		Lee M-R: "3D Shape Reconstruction of Hybrid Reflectance Using the LMS Algorithm" International Journal of Pattern Recognition and Artificial Intelligence, World Scientific Publishing Company, Singapore, June 2001.								
		Lee K M et al: "Shape From Shading With a Generalized Reflectance Map Model" Computer Vision and Image Understanding, Academic Press, August 1997.								
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Examiner			Date Co	onsidered						
EXAMINE!	R: Initial	if citation considered, whe	ther or not citation	n is in conformance with MPEP § 609 on to the applicant.); Draw line thre	ough citation if	not in conform	nance and		